

N-Channel Enhancement Mode MOSFET

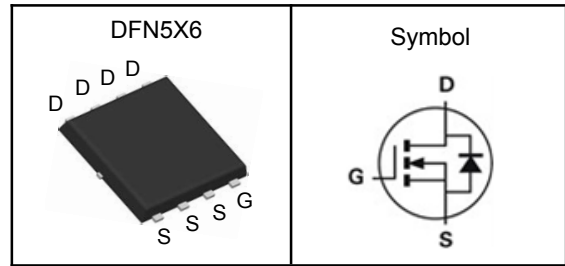
Features

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant
- 100% UIS and Rg Tested

Applications

- Power Management in Desktop Computer
- DC/DC Converters

Pin Description



V_{DSS}	60	V
$R_{DS(ON)-Typ}$	7.5	m Ω
I_D	65	A

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$, Unless Otherwise Noted)

Symbol	Parameter		Rating	Unit
V_{DSS}	Drain-Source Voltage		60	V
V_{GSS}	Gate-Source Voltage		± 20	V
T_J	Maximum Junction Temperature		-55 to 150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range		-55 to 150	$^\circ\text{C}$
EAS	Single Pulse Avalanche Energy ^③		90	mJ
$I_{DM}^{①}$	Pulse Drain Current Tested		204	A
I_D	Continuous Drain Current	$T_C=25^\circ\text{C}$	65	A
P_D	Maximum Power Dissipation	$T_C=25^\circ\text{C}$	80	W

Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	62	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance Junction-Case ₁	1.56	$^\circ\text{C}/\text{W}$

Note ① : Max. current is limited by bonding wire.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C .

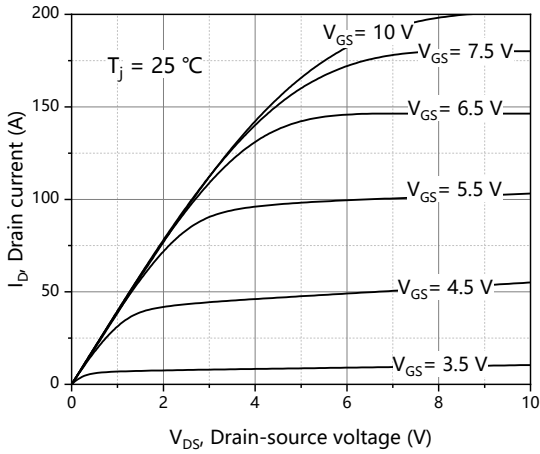
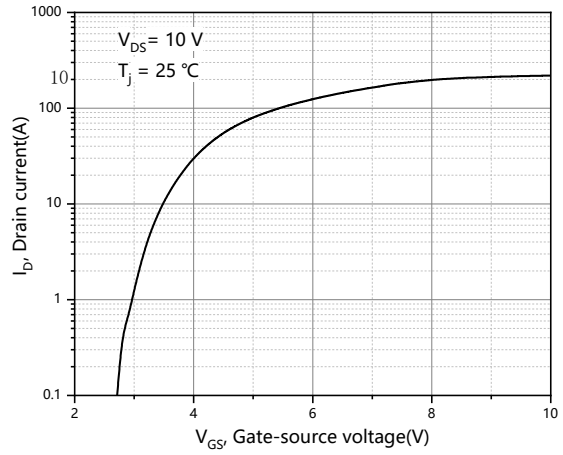
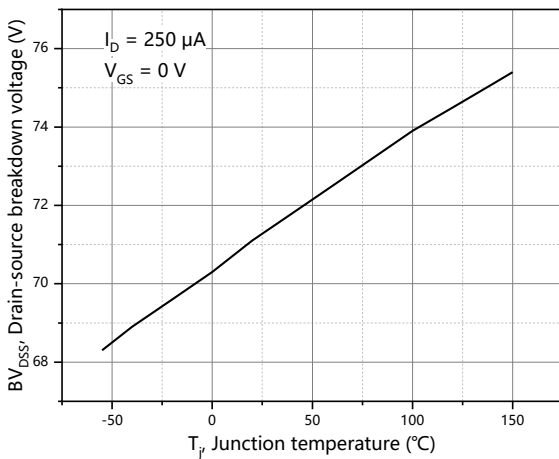
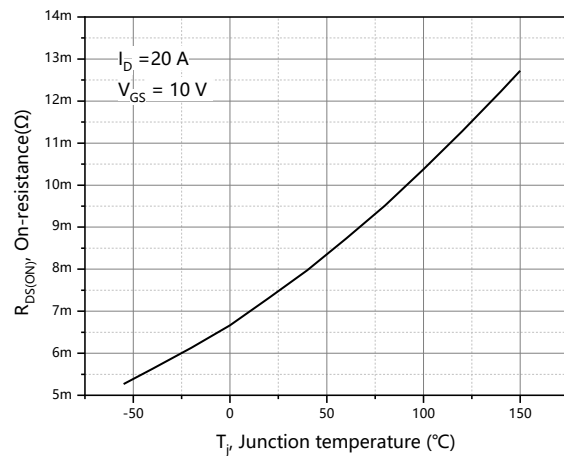
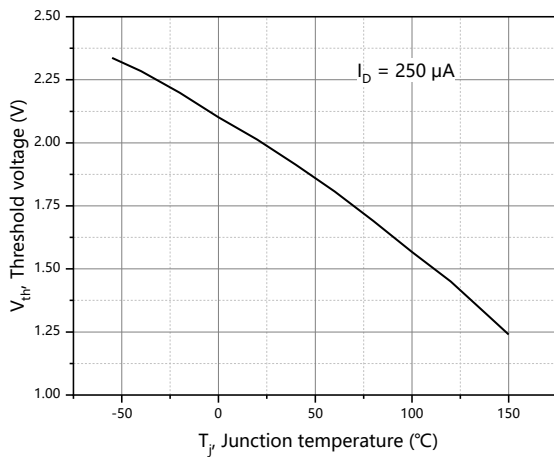
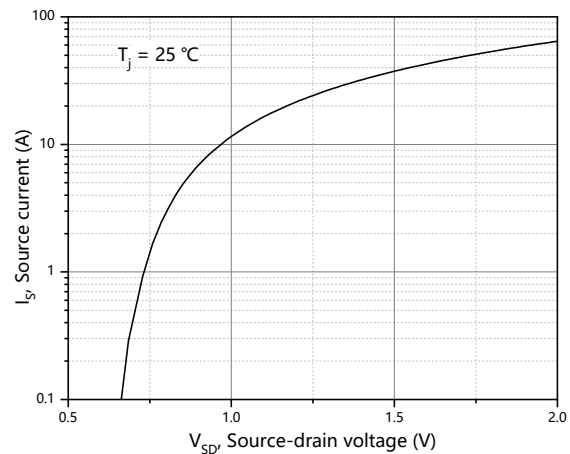
Note ③ : Surface Mounted on 1in^2 FR-4 board with 1oz.

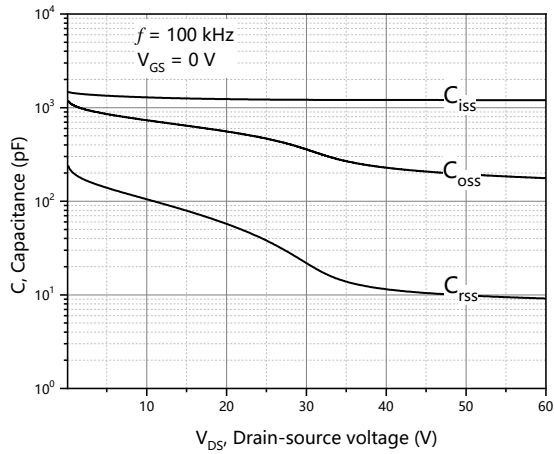
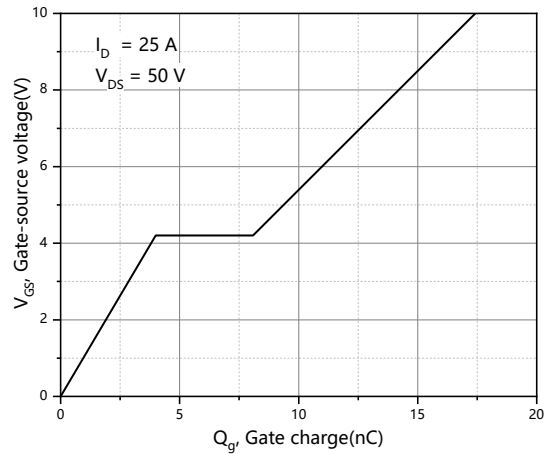
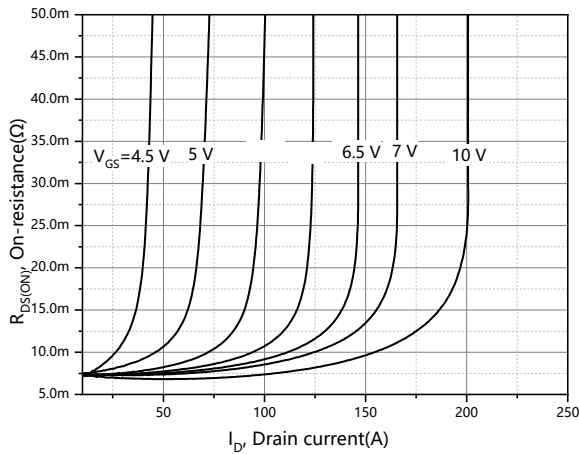
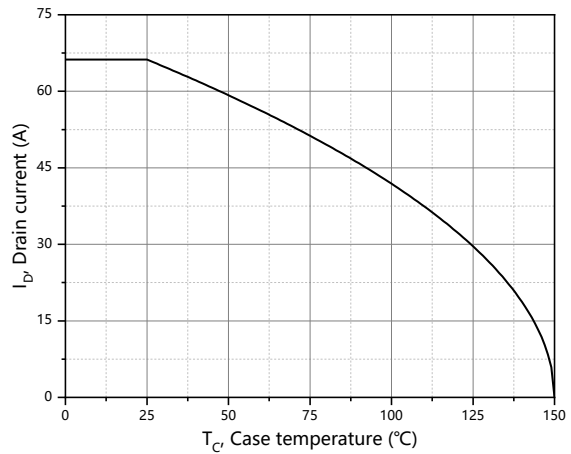
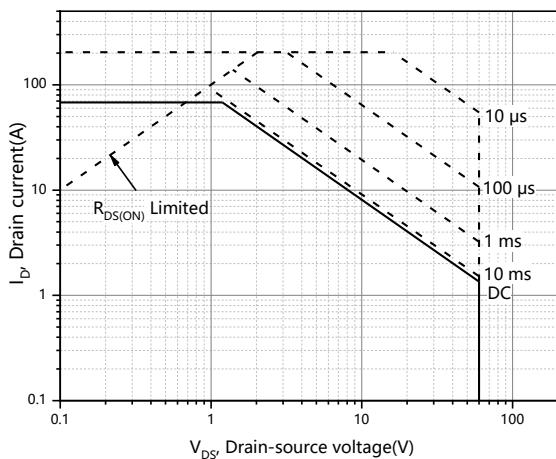
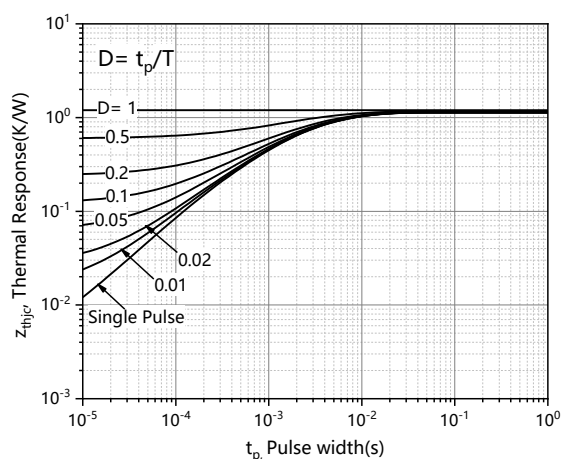
**N-Channel Enhancement Mode MOSFET****Electrical Characteristics** ($T_J=25^\circ\text{C}$, Unless Otherwise Noted)

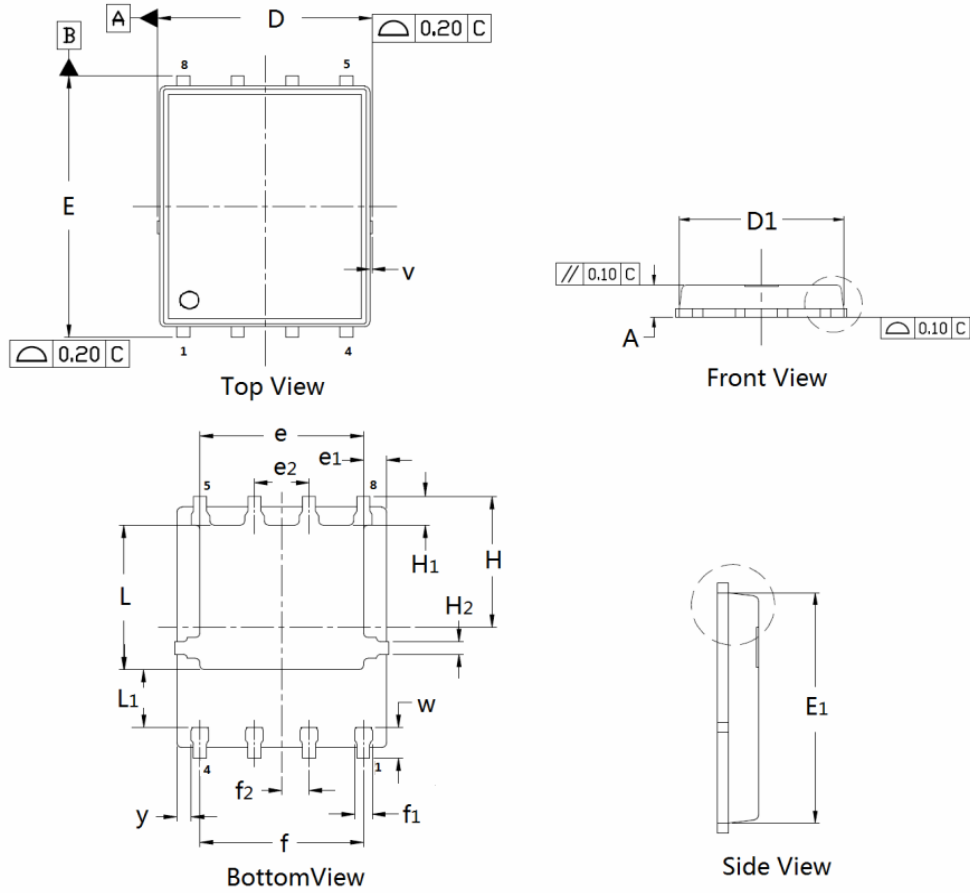
Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
Static Electrical Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	60	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=60V, V_{GS}=0V$	---	---	1	μA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	---	2.5	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---	± 100	nA
$R_{DS(on)}$	Drain-Source On-state Resistance	$V_{GS}=10V, I_D=20A$	---	7.5	10	$m\Omega$
		$V_{GS}=4.5V, I_D=10A$	---	10	14	$m\Omega$
Dynamic Characteristics ^⑤						
C_{iss}	Input Capacitance	$V_{DS}=50V, V_{GS}=0V, \text{Freq.}=1\text{MHz}$	---	1280	---	pF
C_{oss}	Output Capacitance		---	194	---	
C_{riss}	Reverse Transfer Capacitance		---	10	---	
$T_{d(on)}$	Turn-on Delay Time	$V_{DS}=50V, V_{GS}=10V, I_D=25A, R_G=2\Omega$	---	23.9	---	nS
T_r	Turn-on Rise Time		---	4.6	---	
$T_{d(off)}$	Turn-off Delay Time		---	37.8	---	
T_f	Turn-off Fall Time		---	4.6	---	
Q_g	Total Gate Charge	$V_{DS}=50V, V_{GS}=10V, I_D=25A$	---	17.5	---	nC
Q_{gs}	Gate-Source Charge		---	3.8	---	
Q_{gd}	Gate-Drain Charge		---	4.2	---	
Source-Drain Characteristics						
V_{SD}	Diode Forward Voltage	$I_S=20A, V_{GS}=0V$	---	---	1.3	V
t_{rr}	Reverse Recovery Time	$I_F=20A, V_{GS}=0V, di/dt=100A/\mu s$	---	42.6	---	nS
Q_{rr}	Reverse Recovery Charge		---	36.3	---	nC

Note ④: Pulse test (pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$).

Note ⑤: Guaranteed by design, not subject to production testing.

N-Channel Enhancement Mode MOSFET
Typical Characteristics

Figure 1. Typ. output characteristics

Figure 2. Typ. transfer characteristics

Figure 3. Drain-source breakdown voltage

Figure 4. Drain-source on-state resistance

Figure 5. Threshold voltage

Figure 6. Forward characteristic of body diode

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Figure 7. Typ. capacitances

Figure 8. Typ. gate charge

Figure 9. Drain-source on-state resistance

Figure 10. Drain current

Figure 11. Safe operation area $T_C=25\text{ }^\circ\text{C}$

Figure 12. Max. transient thermal impedance

N-Channel Enhancement Mode MOSFET
DFN5×6 Package Outline Data

DIMENSIONS (unit : mm)

Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
A	0.90	1.02	1.10	D	4.90	4.98	5.10
D ₁	4.80	4.89	5.10	E	5.90	6.11	6.25
E ₁	5.65	5.74	5.95	e	3.72	3.80	3.92
e ₁	--	0.5	--	e ₂	--	1.	--
f	--	3.8	--	f ₁	0.31	0.37	0.51
f ₂	--	0.6	--	H	--	3.	--
H ₁	0.59	0.63	0.79	H ₂	0.26	0.28	0.32
L	3.35	3.45	3.65	L ₁	--	1.	--
v	--	0.1	--	w	0.64	0.68	0.84
y	--	0.3	--		--		--